

Notice of References Cited	Application/Control No. 10/020,926	Applicant(s)/Patent Under Reexamination CHEN ET AL.	
	Examiner Yuwen Pan	Art Unit 2682	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,112,101	08-2000	Bhatia et al.	455/512
	B	US-6,868,277	03-2005	Cerwall et al.	455/509
	C	US-			
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	F	US-			
	G	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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